

Atomic Resolution Electron Tomography

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Visualizing the arrangement of atoms has played an important role in the evolution of modern science and technology. Crystallography has long been used to reveal globally averaged 3D atomic structures. Scanning probe microscopes can determine surface structures at atomic level. Electron microscopes can resolve atoms in 2D projections of 3D crystalline samples. In this talk, we will present a general tomographic method for determining the 3D local structure of materials at atomic resolution. By combining scanning transmission electron microscopy with a novel data acquisition and image reconstruction method known as equally sloped tomography, we achieve electron tomography at 2.4 Å resolution and observe nearly all the atoms in a multiply-twinned Pt nanoparticle. We find the existence of atomic steps at 3D twin boundaries of the Pt nanoparticle and, for the first time, image the 3D core structure of edge and screw dislocations in materials at atomic resolution. We expect this atomic resolution electron tomography method to find broad applications in materials sciences, nanoscience, solid state physics, chemistry and biology.

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